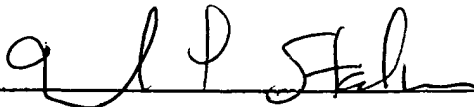


Page 1 of 1

Form PTO-1449 (modified) List of Patents and Publications For Applicant's Information Disclosure Statement (Use several sheets if necessary)		ATTY. DKT. NO. 5589-04001 APPLICANT: Stokowski et al. FILING DATE: October 6, 2003		SERIAL NO. 10/679,857 GROUP: 2877			
U.S. PATENT DOCUMENTS							
EXAM. INITIALS	REF. DES.	DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
M		4,817,123	3/1989	Sones et al.			
		5,453,844	9/1995	George et al.			
		5,459,520	10/1995	Sasaki			
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		5,774,179	6/1998	Chevrette et al.			
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MD		6,266,437	7/2001	Elchel et al.			
		2001/0022858	9/2001	Komiya et al.			
		6,344,640	2/2002	Rhoads			
FOREIGN PATENT DOCUMENTS							
EXAM. INITIALS	REF. DES.	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUB CLASS	TRANSLATION YES/NO
OTHER ART (Including Author, Title, Date, Pertinent Pages, Etc.)							

EXAMINER:

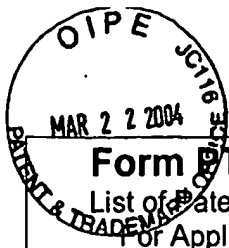


DATE CONSIDERED:

11-30-05

EXAMINER: Initial if citation considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to the patent owner.

Information Disclosure Statement--PTO 1449 (modified)

**Form PTO-1449** (modified)List of Patents and Publications
For Applicant's Information
Disclosure Statement
(Use several sheets if necessary)

ATTY. DKT. NO. 5589-04001

APPLICANT: Stokowski et al.

FILING DATE: October 6, 2003

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U.S. PATENT DOCUMENTS

EXAM. INITIALS	REF. DES.	DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE

FOREIGN PATENT DOCUMENTS

EXAM. INITIALS	REF. DES.	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUB CLASS	TRANSLATION YES/NO
MS	A1	1 061 358	12/2000	EP			
	A2	1 061 571	12/2000	EP			
	A3	1 065 567	1/2001	EP			
	A4	1 066 925	1/2001	EP			
	A5	1 069 609	1/2001	EP			
	A6	99/22310	5/1999	WO			
	A7	99/25004	5/1999	WO			
	A8	99/38002	7/1999	WO			
	A9	99/41434	8/1999	WO			
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MS	A17	Otsu, "A Threshold Selection Method from Gray-Level Histograms," IEEE Transactions on Systems, Man, and Cybernetics, Vol. SMC-9, No. 1, January 1979, pp. 62-66.

EXAMINER:

Michael Stefan

DATE CONSIDERED:

11-30-05

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ELECTRONIC INFORMATION DISCLOSURE STATEMENT

Electronic Version v18

Stylesheet Version v18.0



Title of
Invention

METHODS AND SYSTEMS FOR INSPECTING RETICLES
USING AERIAL IMAGING AND DIE-TO-DATABASE
DETECTION

Application Number: 10/679857



Confirmation Number: 3197

First Named Applicant: Stan Stokowski

Attorney Docket Number: 5589-04001

Search string: (6636301 or 6614520 or 6529621).pn.

US Patent Documents

Note: Applicant is not required to submit a paper copy of cited US Patent Documents

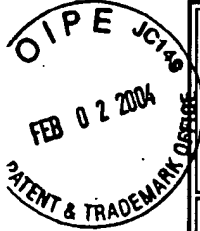
init	Cite.No.	Patent No.	Date	Patentee	Kind	Class	Subclass
	1	6636301	2003-10-21	Kvamme et al.			
	2	6614520	2003-09-02	Bareket et al.			
	3	6529621	2003-03-04	Glasser et al.			

Signature

Examiner Name	Date
	11-30-05

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Search string: (5980187 or 5619548 or 6104835 or 6233719
 or 5991699 or 5689614 or 4247203 or 4347001
 or 4378159 or 4448532 or 4532650 or 4555798
 or 4579455 or 4633504 or 4641967 or 4758094
 or 4766324 or 4805123 or 4845558 or 4877326
 or 4926489 or 5189481 or 5563702 or 5572598
 or 5737072 or 5889593 or 6052478 or 6076465
 or 6122046 or 6137570 or 6141038 or 6175645
 or 6282309 or 6363166).pn.

US Patent Documents

Note: Applicant is not required to submit a paper copy of cited US Patent Documents

init	Cite.No.	Patent No.	Date	Patentee	Kind	Class	Subclass
M	1	5980187	1999-11-09	Verhovsky			
M	2	5619548	1997-04-08	Koppel			
M	3	6104835	2000-08-15	Han			
M	4	6233719	2001-05-15	Hardikar et al.			
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M	7	4247203	1981-01-27	Levy et al.			
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M	23	5563702	1996-10-08	Emery et al.
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W	33	6282309	2001-08-28	Emery
M	34	6363166	2002-03-26	Wihl et al.

Signature

Examiner Name	Date
Michael Steh	11-30-05